

General Description

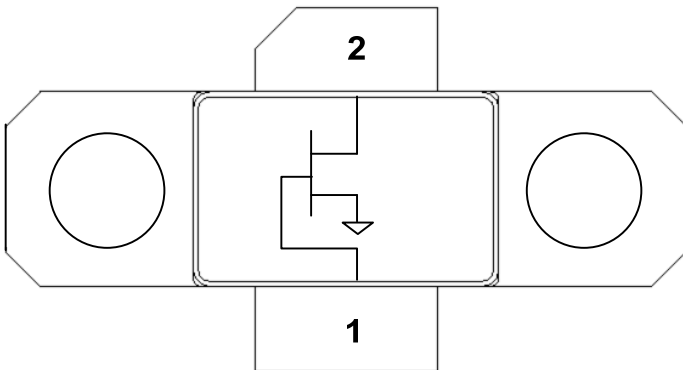
The QPD1008L is a 125 W (P_{3dB}) wideband unmatched discrete GaN on SiC HEMT which operates from DC to 3.2 GHz with a 50V supply rail. The device is in an industry standard air cavity package and is ideally suited for military and civilian radar, land mobile and military radio communications, avionics, and test instrumentation. The device can support pulsed, CW, and linear operation.

Lead-free and ROHS compliant

Evaluation boards are available upon request.



Functional Block Diagram



Product Features

- Frequency: DC to 3.2 GHz
 - Output Power (P_{3dB})¹: 162 W
 - Linear Gain¹: 17.5 dB
 - Typical PAE_{3dB}¹: 72%
 - Operating Voltage: 50 V
 - Low thermal resistance package
 - CW and Pulse capable
- Note 1: @ 2 GHz

Applications

- Military radar
- Civilian radar
- Land mobile and military radio communications
- Test instrumentation
- Wideband or narrowband amplifiers
- Jammers
- Avionics

Ordering info

Part No.	ECCN	Description
QPD1008L	EAR99	DC–3.2GHz RF Transistor
QPD1008LPCB4B01	EAR99	0.96 – 1.215 GHz EVB
QPD1008LEVB2	EAR99	1.1 – 1.5 GHz EVB

Absolute Maximum Ratings¹

Parameter	Rating	Units
Breakdown Voltage, BV_D	+145	V
Gate Voltage Range, V_G	-7 to +2	V
Drain Current, $I_{D_{MAX}}$	20.4	A
Gate Current Range, I_G	See page 7.	mA
Power Dissipation, CW, P_{DISS} , Base Temperature = 85 °C	79	W
RF Input Power, CW, 50 Ω , T = 25 °C	+40	dBm
Channel Temperature, T_{CH}	275	°C
Mounting Temperature (30 Seconds)	320	°C
Storage Temperature	-40 to +150	°C

Notes:

1. . Operation of this device outside the parameter ranges given above may cause permanent damage.

Recommended Operating Conditions¹

Parameter	Min	Typ	Max	Units
Operating Temperature Range	-40	+25	+85	°C
Drain Voltage Range, V_D	+12	+50	+55	V
Drain Current, I_D^3	–	4.0	–	A
Drain Bias Current, I_{DQ}	–	260	–	mA
Gate Voltage, V_G^4	–	-2.8	–	V
Channel Temperature (T_{CH})	–	–	250	°C
Power Dissipation, CW (P_D) ²	–	–	71	W
Power Dissipation, Pulsed (P_D) ^{2, 3}	–	–	127	W

Notes:

1. Electrical performance is measured under conditions noted in the electrical specifications table. Specifications are not guaranteed over all recommended operating conditions.
2. Package at 85 °C
3. Drain current at P3dB, Pulse Width = 128 μ S, Duty Cycle = 10%
4. To be adjusted for desired I_{DQ}

Pulsed Characterization – Load-Pull Performance – Power Tuned¹

Parameters	Typical Values			Unit
	1	2	3	
Frequency, F	1	2	3	GHz
Linear Gain, G_{LIN}	22.5	17.5	14.1	dB
Output Power at 3dB compression point, P_{3dB}	52.1	52.1	51.9	dBm
Power-Added-Efficiency at 3dB compression point, PAE_{3dB}	62.7	59.9	54.3	%
Gain at 3dB compression point	19.5	14.4	11.1	dB

Notes:

1. Test conditions unless otherwise noted: $V_D = +50$ V, $I_D = 260$ mA, Temp = +25 °C

Pulsed Characterization – Load-Pull Performance – Efficiency Tuned¹

Parameters	Typical Values			Unit
	1	2	3	
Frequency	1	2	3	GHz
Linear Gain, G_{LIN}	23.5	18.6	15.2	dB
Output Power at 3dB compression point, P_{3dB}	48.2	50.2	51.0	dBm
Power-Added-Efficiency at 3dB compression point, PAE_{3dB}	75.5	72.6	65.5	%
Gain at 3dB compression point, G_{3dB}	20.5	15.6	12.2	dB

Notes:

1. Test conditions unless otherwise noted: $V_D = +50$ V, $I_{DQ} = 260$ mA, Temp = +25 °C

RF Characterization – EVB1 Performance at 1.09 GHz¹

Parameter	Min	Typ	Max	Units
Linear Gain, G_{LIN}	–	20	–	dB
Output Power at 3dB compression point, P_{3dB}	–	51.2	–	dBm
Drain Efficiency at 3dB compression point, $DEFF_{3dB}$	–	73.5	–	%
Gain at 3dB compression point, G_{3dB}	–	17	–	dB

Notes:

1. $V_D = +50$ V, $I_{DQ} = 260$ mA, Temp = +25 °C, Pulse Width = 128 μ S, Duty Cycle = 10%

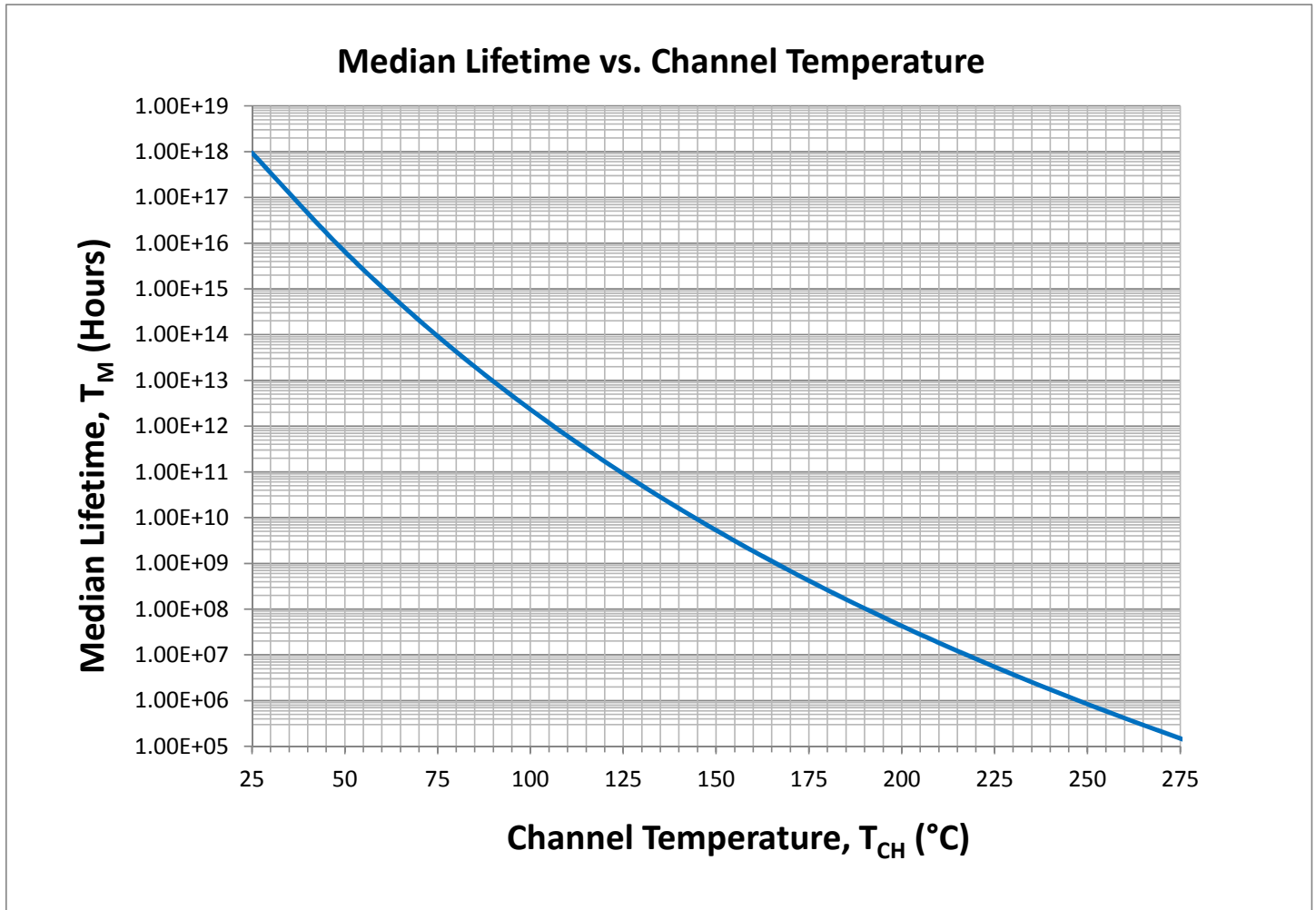
RF Characterization – Mismatch Ruggedness at 1.09 GHz

Symbol	Parameter	dB Compression	Typical
VSWR	Impedance Mismatch Ruggedness	3	10:1

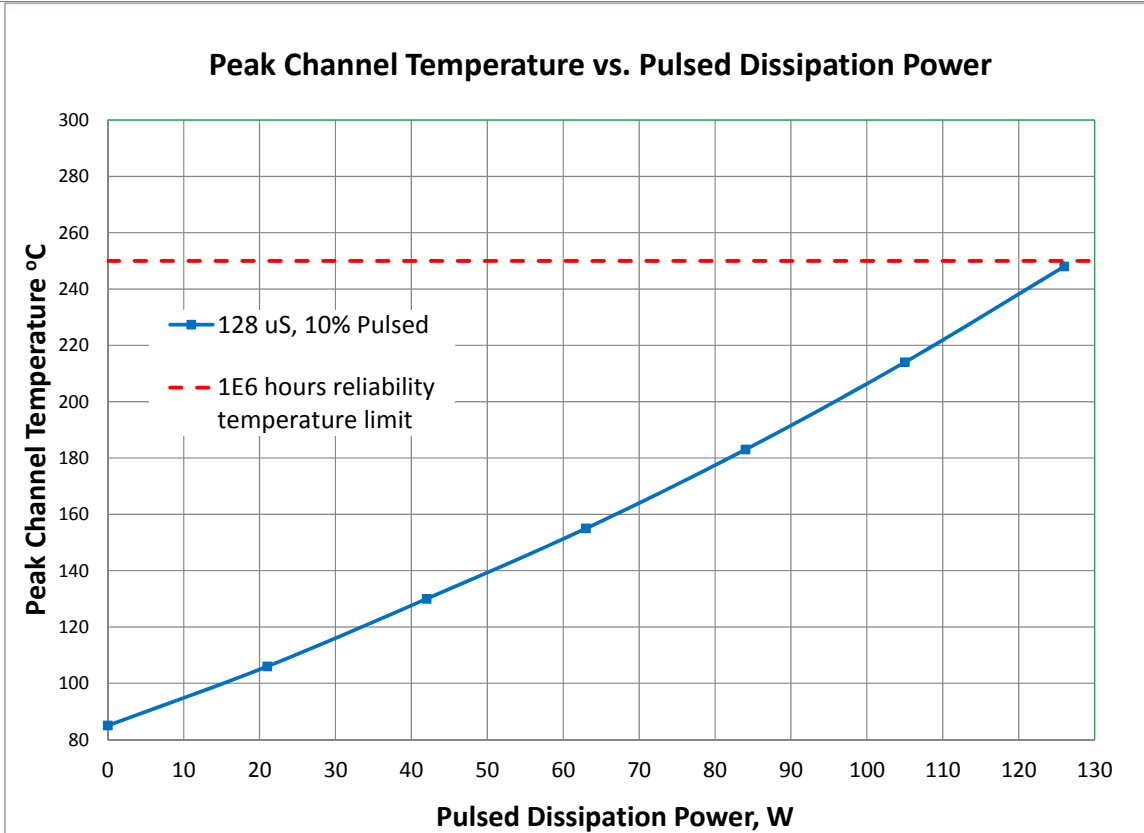
 Test conditions unless otherwise noted: $T_A = 25$ °C, $V_D = 50$ V, $I_{DQ} = 260$ mA

Driving input power is determined at pulsed 3dB compression under matched condition at EVB output connector.

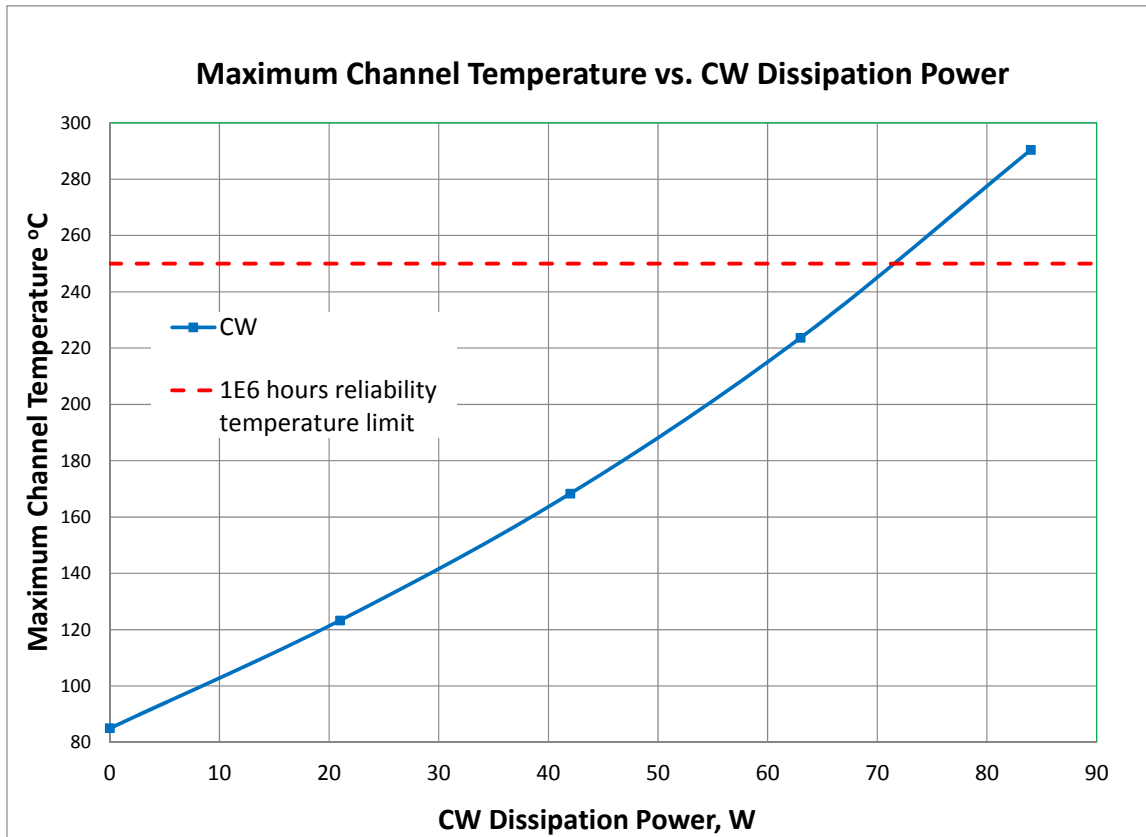
Median Lifetime¹



¹ For pulsed signals, average lifetime is average lifetime at maximum channel temperature divided by duty cycle.

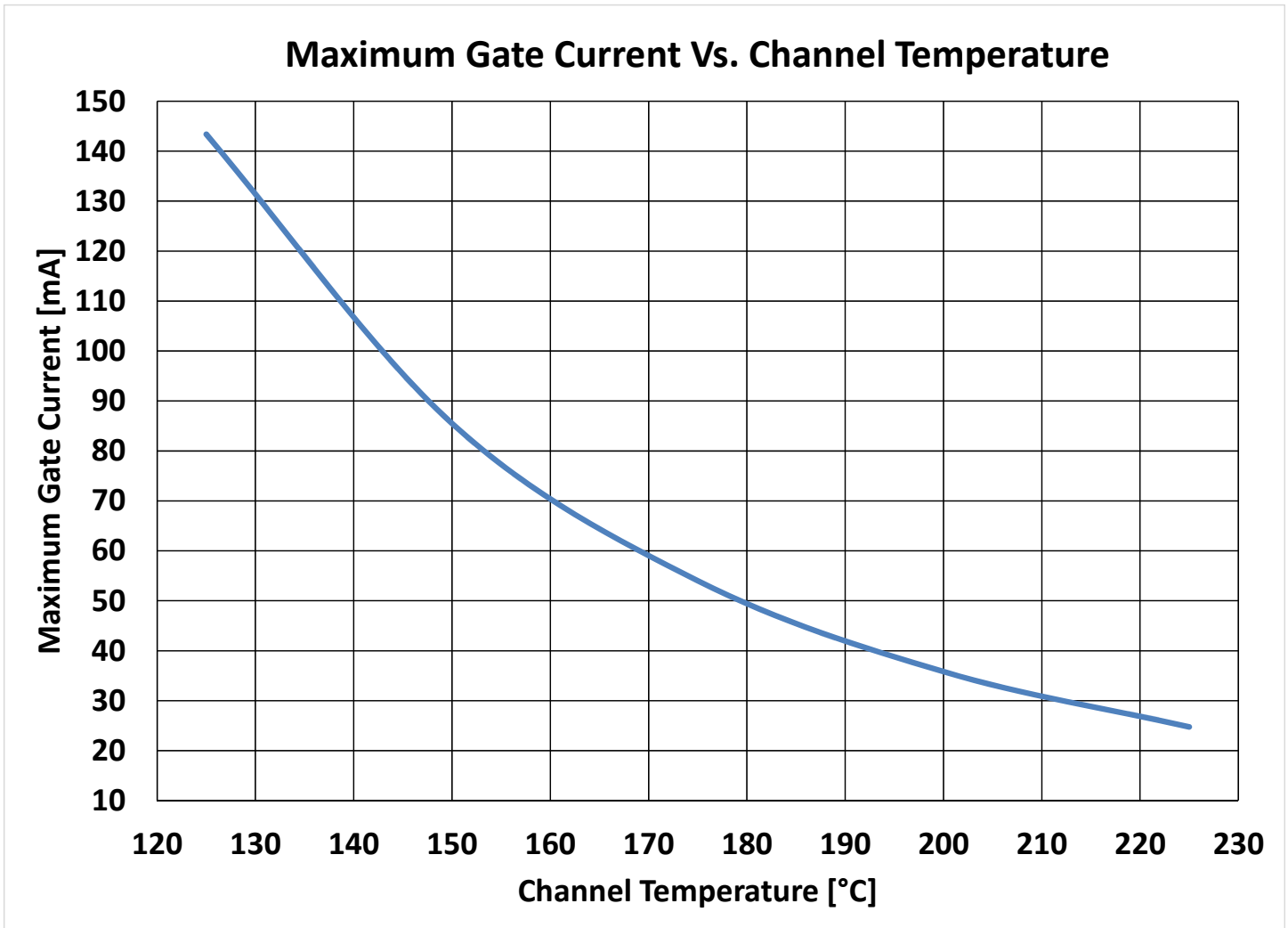
Thermal and Reliability Information - Pulsed


Parameter	Conditions	Values	Units
Thermal Resistance (θ_{JC})	85 °C Case	1.00	°C/W
Peak Channel Temperature (T_{CH})	21 W Pdiss, 128 uS PW, 10% DC	106	°C
Median Lifetime (T_M)		1.1E13	Hrs
Thermal Resistance (θ_{JC})	85 °C Case	1.07	°C/W
Peak Channel Temperature (T_{CH})	42 W Pdiss, 128 uS PW, 10% DC	130	°C
Median Lifetime (T_M)		5.2E11	Hrs
Thermal Resistance (θ_{JC})	85 °C Case	1.11	°C/W
Peak Channel Temperature (T_{CH})	63 W Pdiss, 128 uS PW, 10% DC	155	°C
Median Lifetime (T_M)		3.2E10	Hrs
Thermal Resistance (θ_{JC})	85 °C Case	1.17	°C/W
Peak Channel Temperature (T_{CH})	84 W Pdiss, 128 uS PW, 10% DC	183	°C
Median Lifetime (T_M)		2.0E9	Hrs
Thermal Resistance (θ_{JC})	85 °C Case	1.23	°C/W
Peak Channel Temperature (T_{CH})	105 W Pdiss, 128 uS PW, 10% DC	214	°C
Median Lifetime (T_M)		1.4E8	Hrs
Thermal Resistance (θ_{JC})	85 °C Case	1.29	°C/W
Peak Channel Temperature (T_{CH})	126 W Pdiss, 128 uS PW, 10% DC	248	°C
Median Lifetime (T_M)		9.8E6	Hrs

Thermal and Reliability Information - CW


Parameter	Conditions	Values	Units
Thermal Resistance (θ_{JC})	85 °C Case	1.82	°C/W
Maximum Channel Temperature (T_{CH})	21 W P_{diss} , CW	123	°C
Median Lifetime (T_M)		1.2E11	Hrs
Thermal Resistance (θ_{JC})	85 °C Case	1.98	°C/W
Maximum Channel Temperature (T_{CH})	42 W P_{diss} , CW	168	°C
Median Lifetime (T_M)		8.5E8	Hrs
Thermal Resistance (θ_{JC})	85 °C Case	2.20	°C/W
Maximum Channel Temperature (T_{CH})	63 W P_{diss} , CW	224	°C
Median Lifetime (T_M)		6.0E6	Hrs
Thermal Resistance (θ_{JC})	85 °C Case	2.45	°C/W
Maximum Channel Temperature (T_{CH})	84 W P_{diss} , CW	290	°C
Median Lifetime (T_M)		5.6E4	Hrs

Maximum Gate Current Vs. Channel Temperature

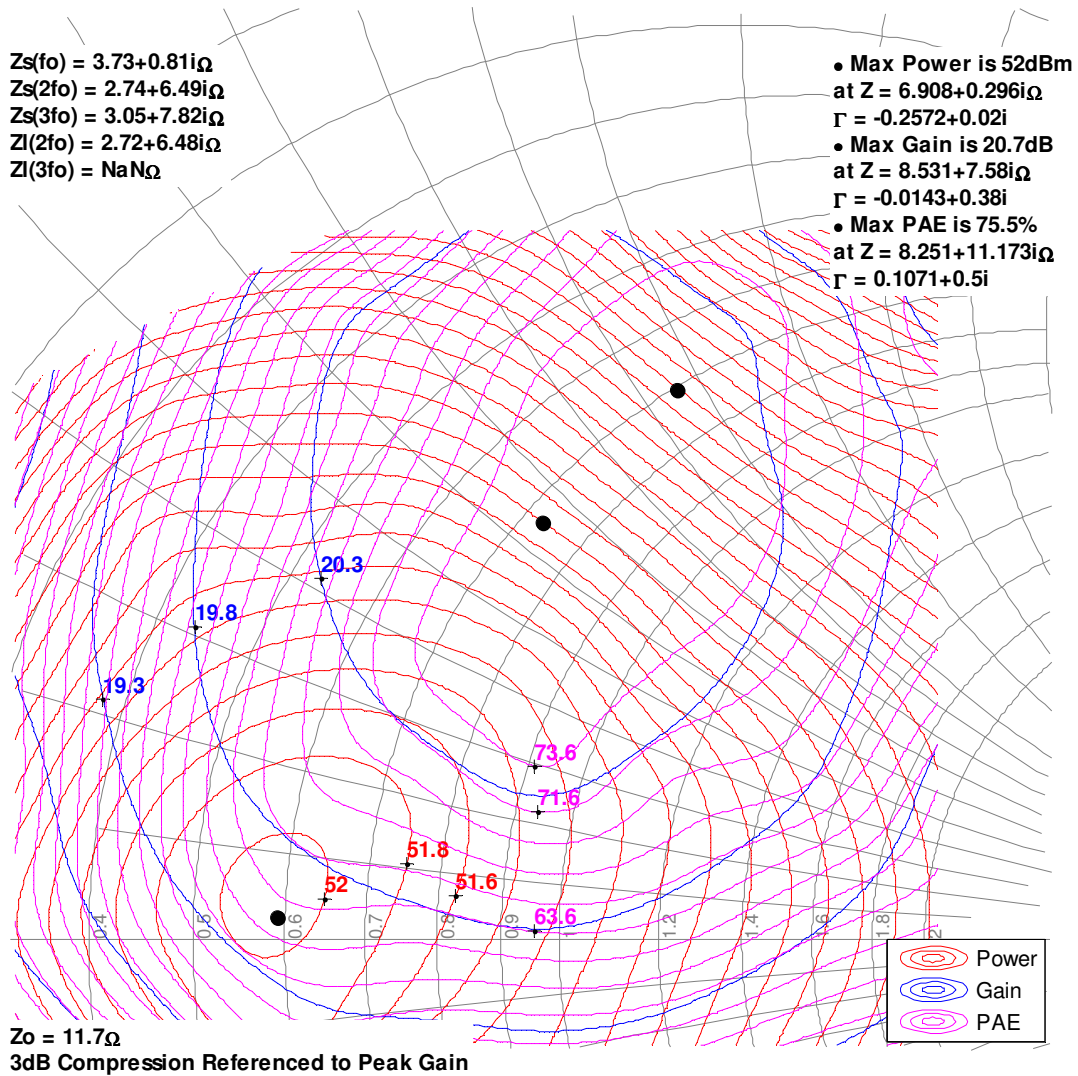


Load-Pull Smith Charts^{1, 2, 3}

Notes:

1. 50 V, 260 mA, Pulsed signal with 128 uS pulse width and 10 % duty cycle. Performance is at indicated input power.
2. See page 16 for load-pull and source-pull reference planes. 11.7-Ω load-pull TRL fixtures are built with 32-mil RO4360G2 material.
3. NaN means the impedances are either undefined or varying in load-pull system.

1GHz, Load-pull

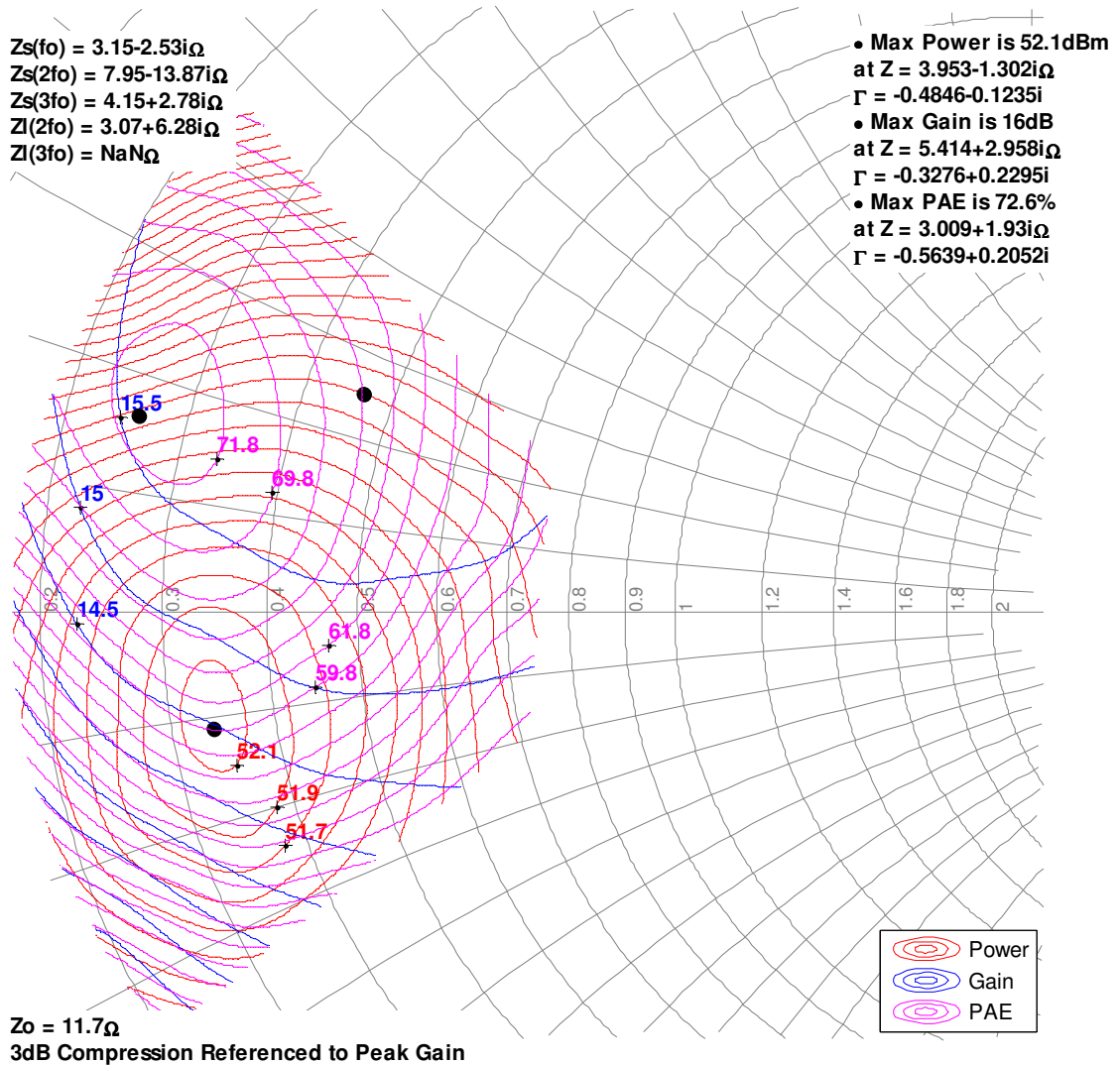


Load-Pull Smith Charts^{1, 2, 3}

Notes:

1. 50 V, 260 mA, Pulsed signal with 128 uS pulse width and 10 % duty cycle. Performance is at indicated input power.
2. See page 16 for load-pull and source-pull reference planes. 11.7-Ω load-pull TRL fixtures are built with 32-mil RO4360G2 material.
3. NaN means the impedances are either undefined or varying in load-pull system.

2GHz, Load-pull

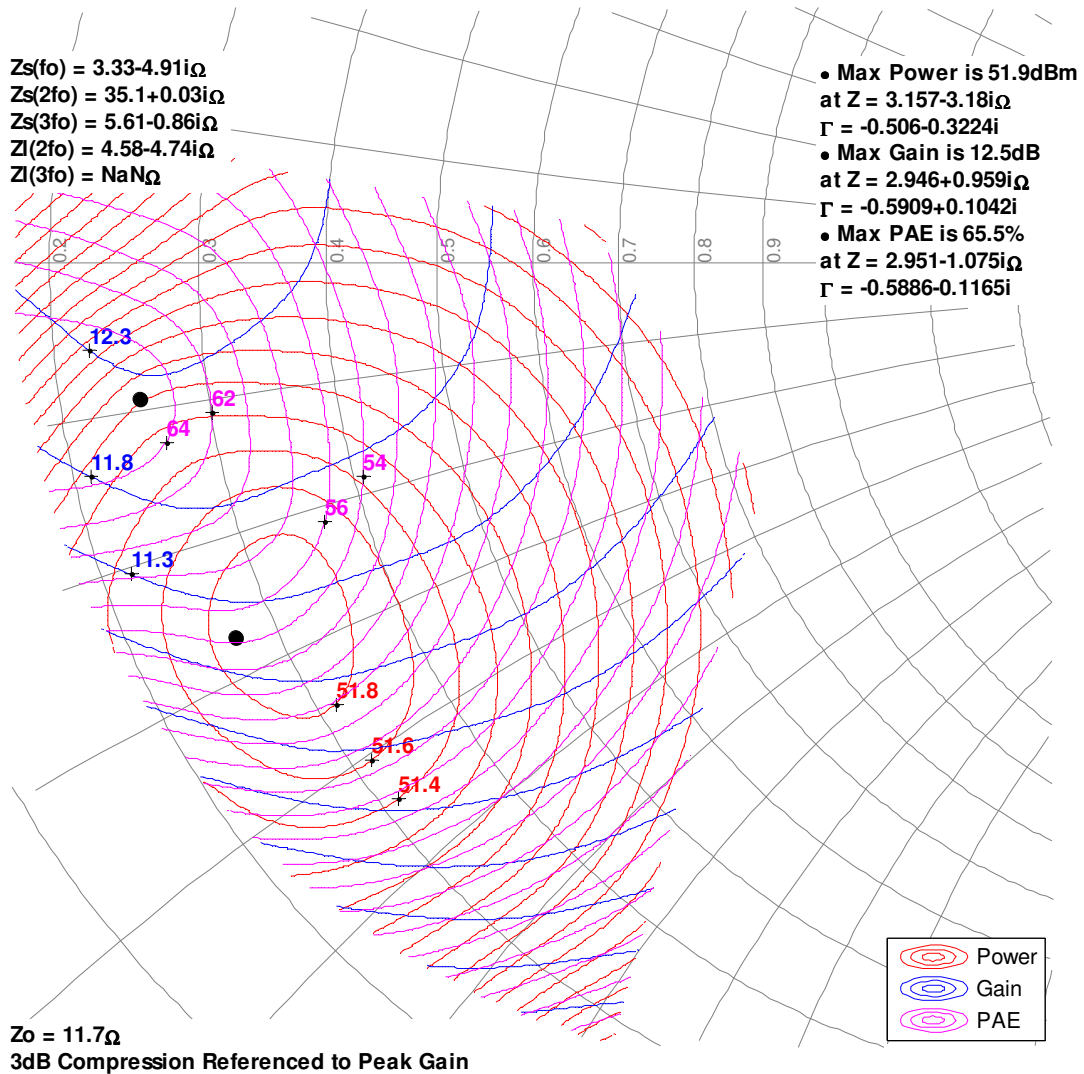


Load-Pull Smith Charts^{1, 2, 3}

Notes:

1. 50 V, 260 mA, Pulsed signal with 128 uS pulse width and 10 % duty cycle. Performance is at indicated input power.
2. See page 16 for load-pull and source-pull reference planes. 11.7-Ω load-pull TRL fixtures are built with 32-mil RO4360G2 material.
3. NaN means the impedances are either undefined or varying in load-pull system.

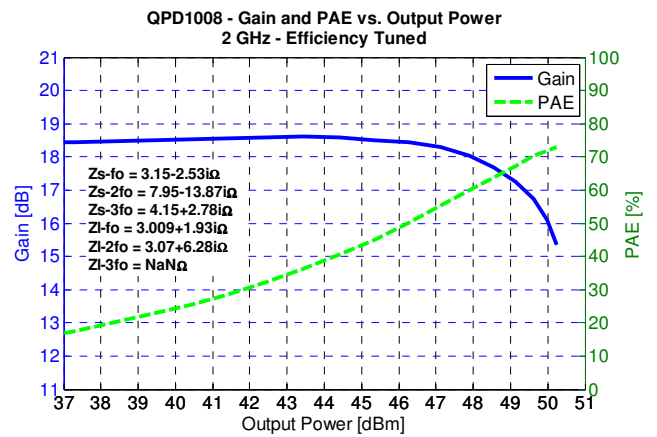
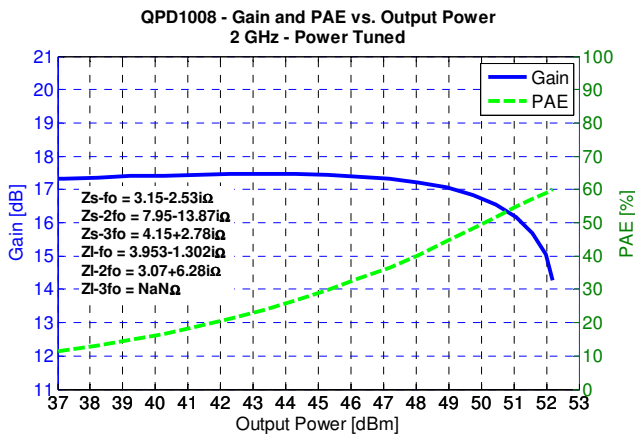
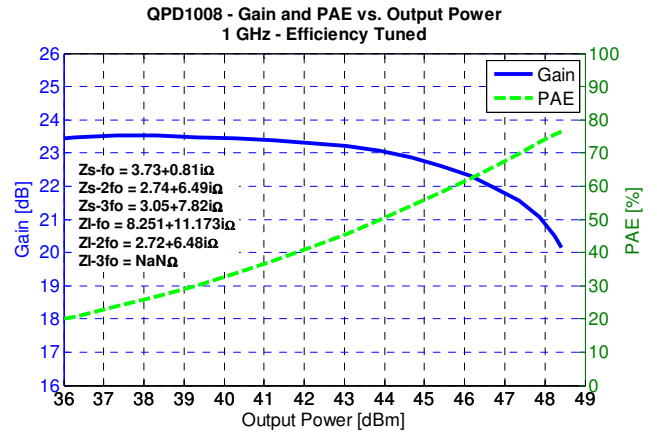
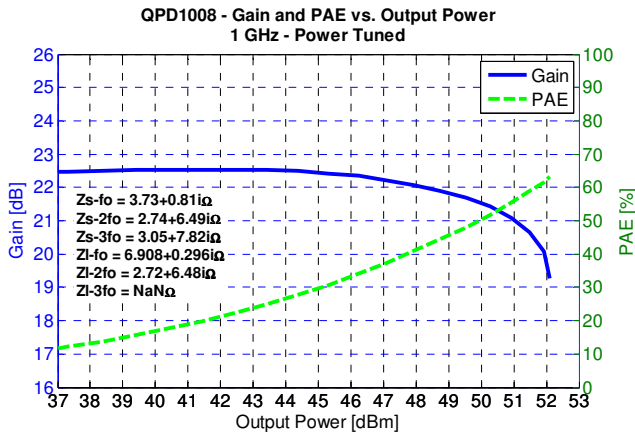
3GHz, Load-pull



Typical Performance – Load-Pull Drive-up

Notes:

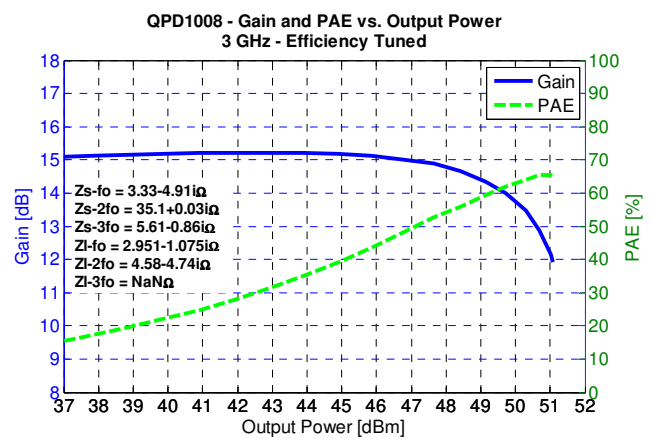
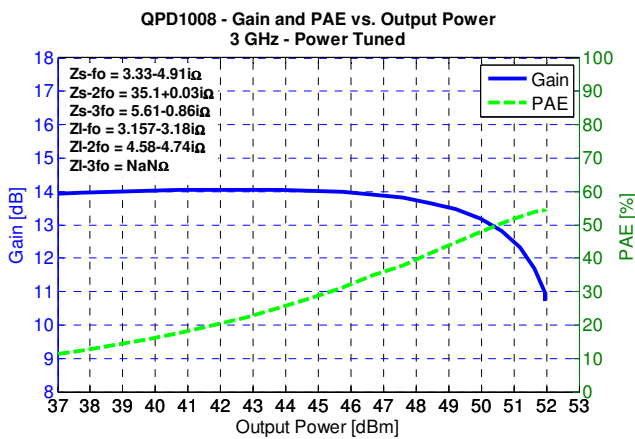
1. Pulsed signal with 128 uS pulse width and 10 % duty cycle, $V_d = 50\text{ V}$, $I_{DQ} = 260\text{ mA}$
2. See page 16 for load-pull and source-pull reference planes where the performance was measured.



Typical Performance – Load-Pull Drive-up

Notes:

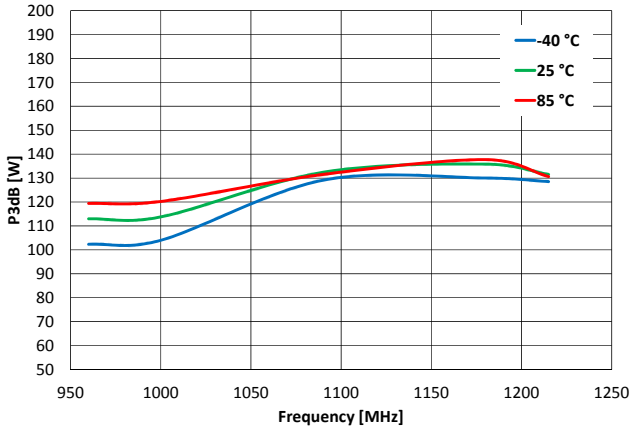
3. Pulsed signal with 128 uS pulse width and 10 % duty cycle, $V_d = 50\text{ V}$, $I_{DQ} = 260\text{ mA}$
4. See page 16 for load-pull and source-pull reference planes where the performance was measured.



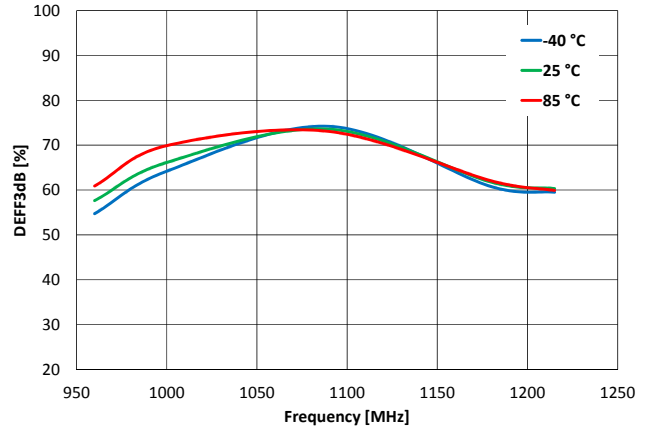
Power Driveup Performance Over Temperatures Of 0.96 – 1.215 GHz EVB¹

1. Pulsed signal with 128 uS pulse width and 10 % duty cycle, $V_d = 50\text{ V}$, $I_{DQ} = 260\text{ mA}$

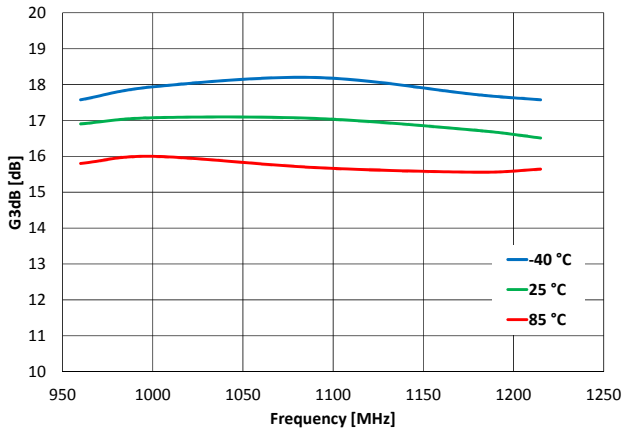
P3dB Over Temperatures



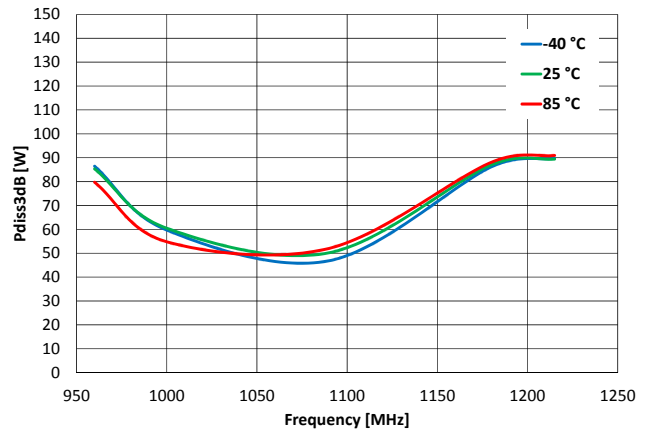
DEFF3dB Over Temperatures



G3dB Over Temperatures



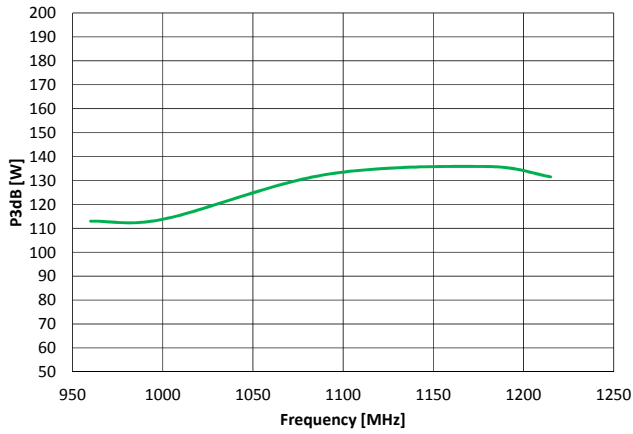
Pdiss3dB Over Temperatures



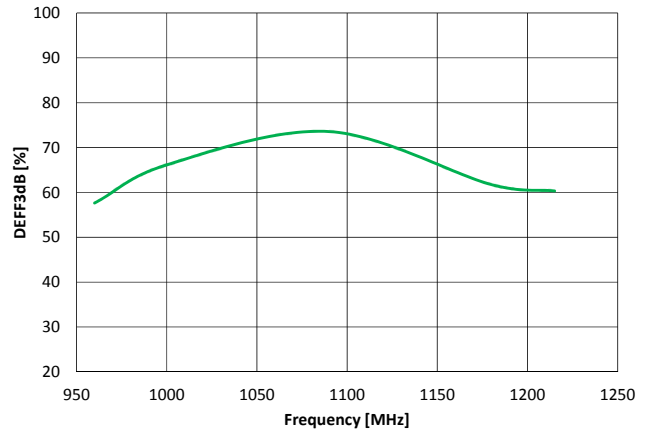
Typical Performance – 0.96 – 1.215 GHz EVB at 25 °C ¹

1. Pulsed signal with 128 μ s pulse width and 10 % duty cycle, $V_d = 50$ V, $I_{DQ} = 260$ mA

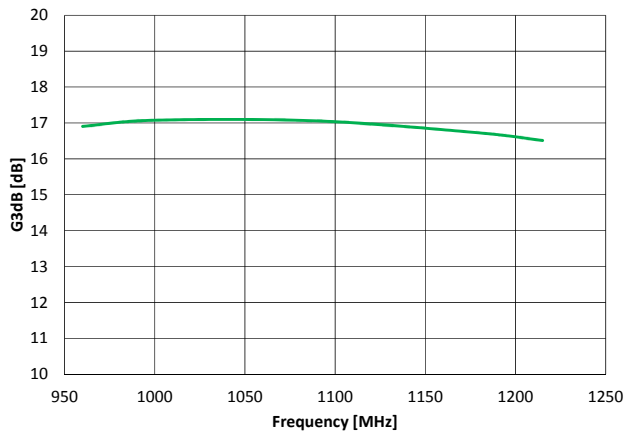
P3dB At 25 °C



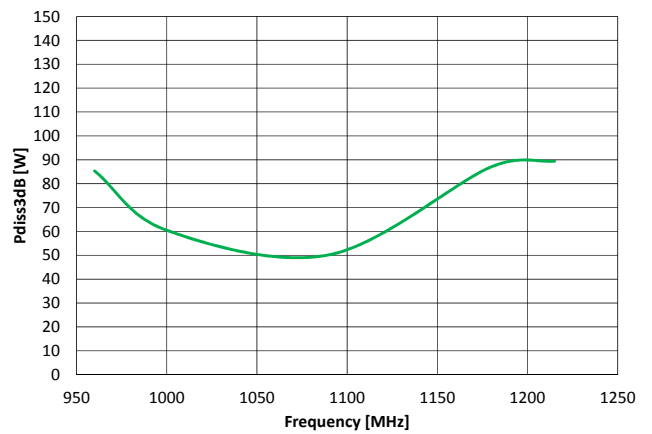
DEFF3dB At 25 °C



G3dB At 25 °C

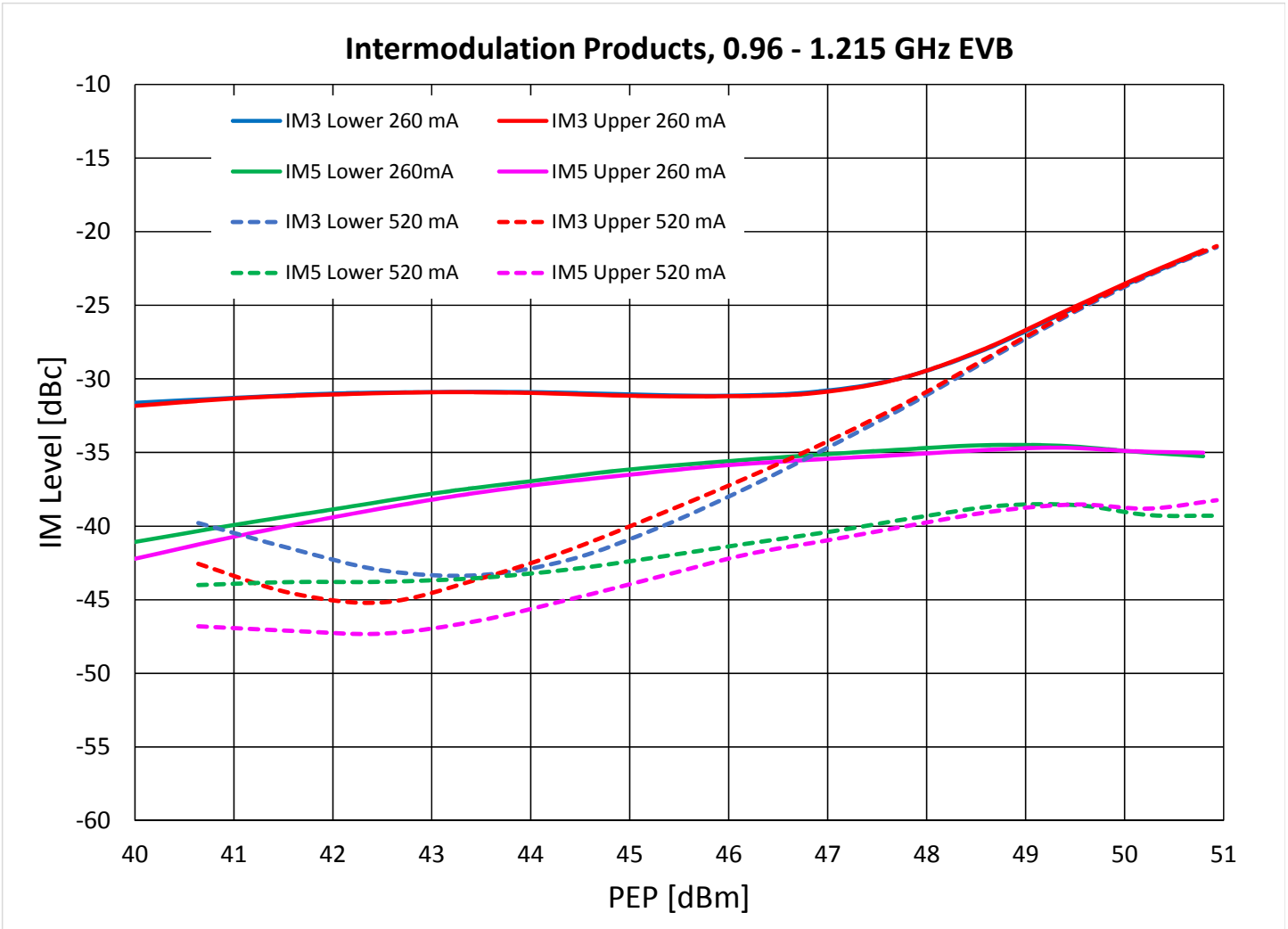


Pdiss3dB At 25 °C



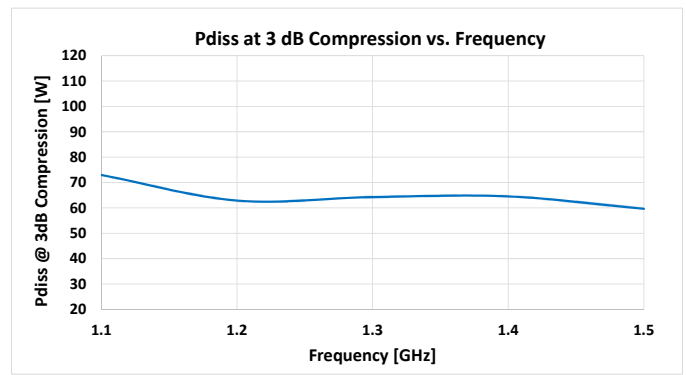
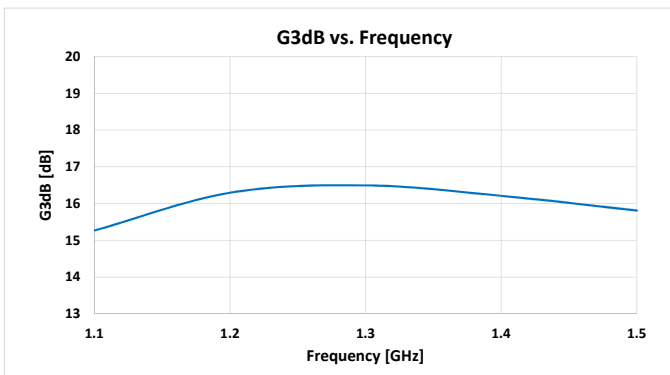
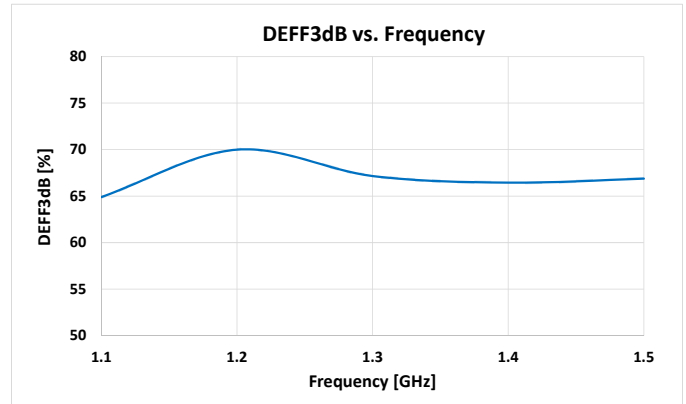
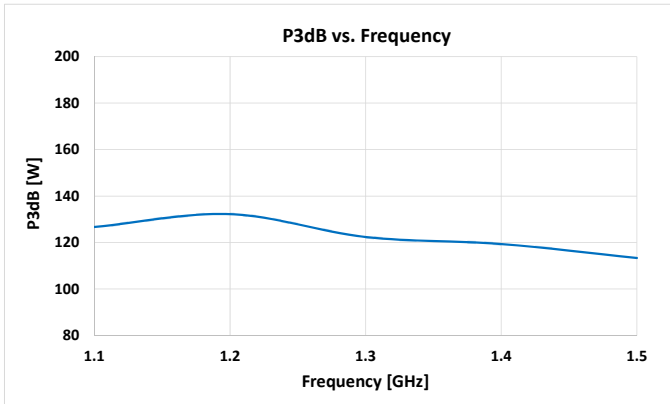
Typical 2-Tone Performance – 0.96 – 1.215 GHz EVB at 25 °C ¹

1. Center Frequency = 1.095 GHz, Tone Spacing = 10 MHz, I_{DQ} = 260 mA and 520 mA

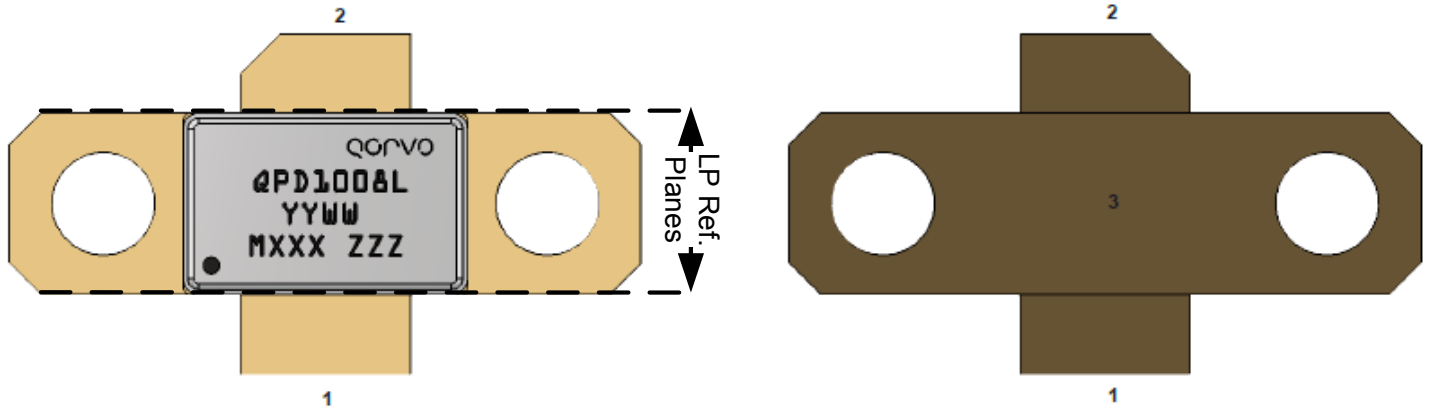


Typical Performance – 1.1 – 1.5 GHz EVB at 25 °C ¹

1. Pulsed signal with 128 μ s pulse width and 10 % duty cycle, $V_d = 50$ V, $I_{DQ} = 260$ mA



Pin Layout¹



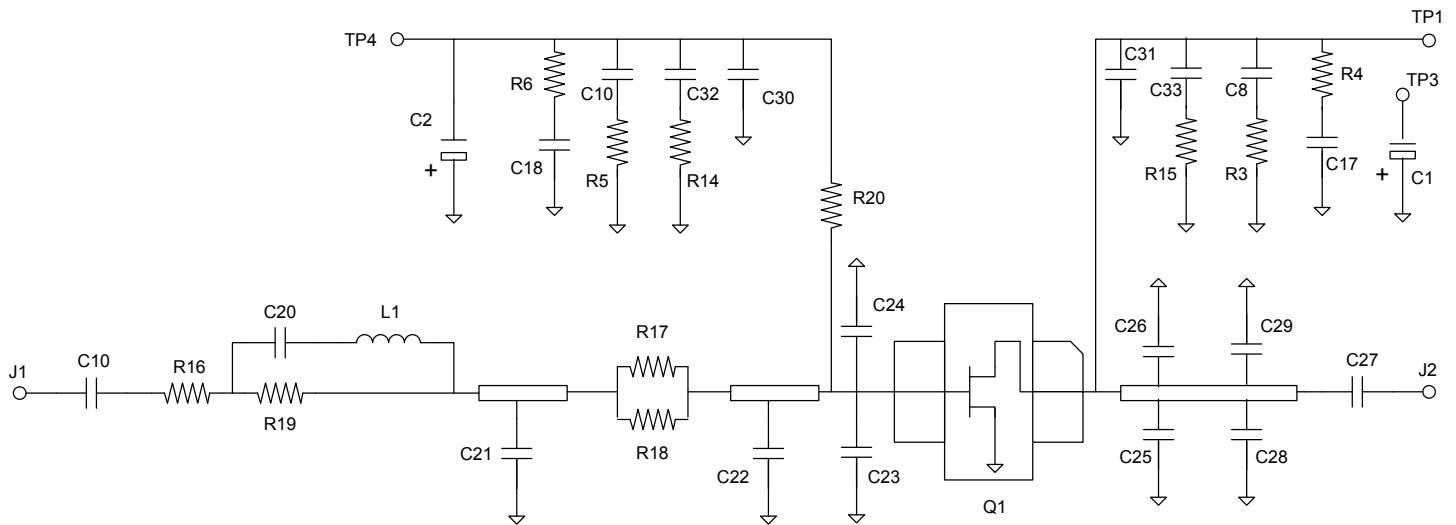
Notes:

- The QPD1008L will be marked with the “QPD1008L” designator and a lot code marked below the part designator. The “YY” represents the last two digits of the calendar year the part was manufactured, the “WW” is the work week of the assembly lot start, the “MXXX” is the production lot number, and the “ZZZ” is an auto-generated serial number.

Pin Description

Pin	Symbol	Description
1	VG / RF IN	Gate voltage / RF Input
2	VD / RF OUT	Drain voltage / RF Output
3	Flange	Source to be connected to ground

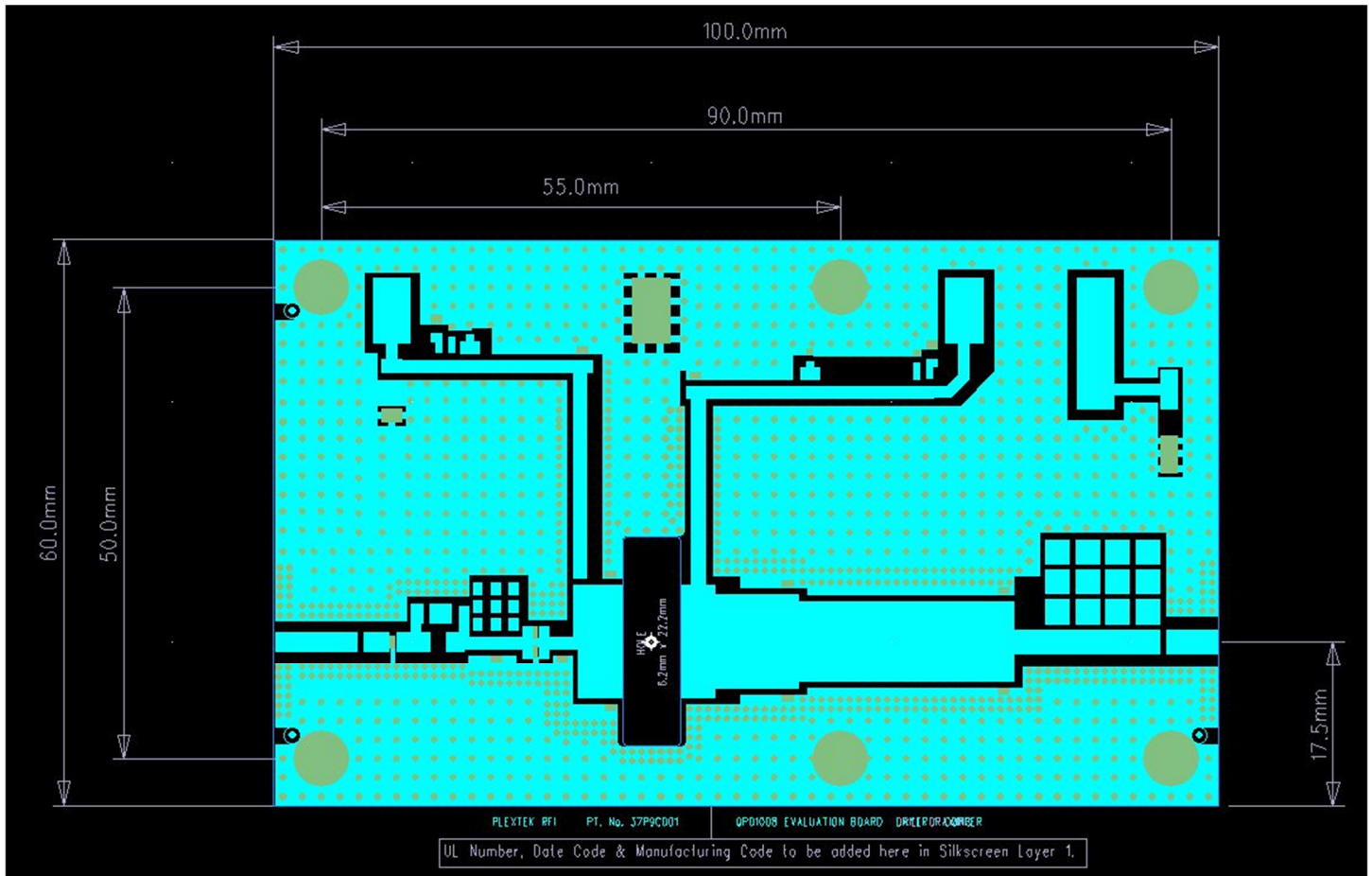
0.96 – 1.215 GHz Application Circuit - Schematic



Bias-up Procedure	Bias-down Procedure
1. Set V_G to -4 V.	1. Turn off RF signal.
2. Set I_D current limit to 300 mA.	2. Turn off V_D
3. Apply 50 V V_D .	3. Wait 2 seconds to allow drain capacitor to discharge
4. Slowly adjust V_G until I_D is set to 260 mA.	4. Turn off V_G
5. Set I_D current limit to 0.6 A (Pulsed operation)	
6. Apply RF.	

0.96 – 1.215 GHz Application Circuit - Layout

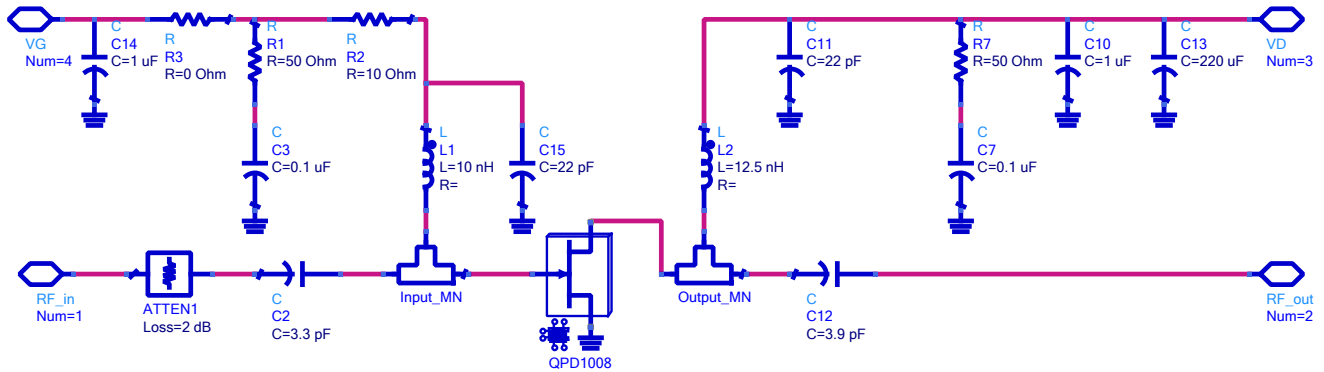
Board material is RO4360G2 0.032" thickness with 1oz copper cladding.



0.96 – 1.215 GHz Application Circuit - Bill Of material

Ref Des	Value	Description	Manufacturer	Part Number
C8, 10	1 nF	X7R 100V 5% 0603 Capacitor	AVX	06031C102JAT2A
C17 - 18	100 nF	X7R 100V 5% 0805 Capacitor	AVX	08051C104JAT2A
C28 - 29	2 pF	RF NPO 250VDC ± 0.1 pF Capacitor	ATC	ATC800A2R0BT250X
C23 – 24	2.4 pF	RF NPO 250VDC ± 0.1 pF Capacitor	ATC	ATC800A2R4BT250X
C20	3.0 pF	RF NPO 250VDC ± 0.1 pF Capacitor	ATC	ATC800A3R0BT250X
C21, 25 – 26	6.2 pF	RF NPO 250VDC ± 0.1 pF Capacitor	ATC	ATC800A6R2BT250X
C22	13 pF	RF NPO 250VDC 1% Capacitor	ATC	ATC800A130FT250X
C19, 27, 30 – 31	56 pF	RF NPO 250VDC 1% Capacitor	ATC	ATC800A560FT250X
C32 - 33	100 pF	RF NPO 250VDC 1% Capacitor	ATC	ATC800A101FT250X
C1	33 uF	RF NPO 250VDC 1% Capacitor	SANYO	63SXV33M
C2	10 uF	RF NPO 250VDC 1% Capacitor	AVX	TPSC106KR0500
J1 - 2		SMA Panel Mount 4-hole Jack	Gigalane	PSF-S00-000
L1	5.6 nH	0805 5% Inductor	COILCRAFT	0805CS-050XJE
R4, 6	1 Ohm	0603 Thick Film Resistor	ANY	
R5	3.3 Ohm	0603 Thick Film Resistor	ANY	
R14 – 15	5.1 Ohm	0603 Thick Film Resistor	ANY	
R3	33 Ohm	0603 Thick Film Resistor	ANY	
R20	3.9 Ohm	0805 Thick Film Resistor	ANY	
R17 – 18	4 Ohm	0805CS High Power Thick Film Resistor	IMS	ND3-0805CS4R00J
R19	510 Ohm	1206 Thick Film Resistor	ANY	

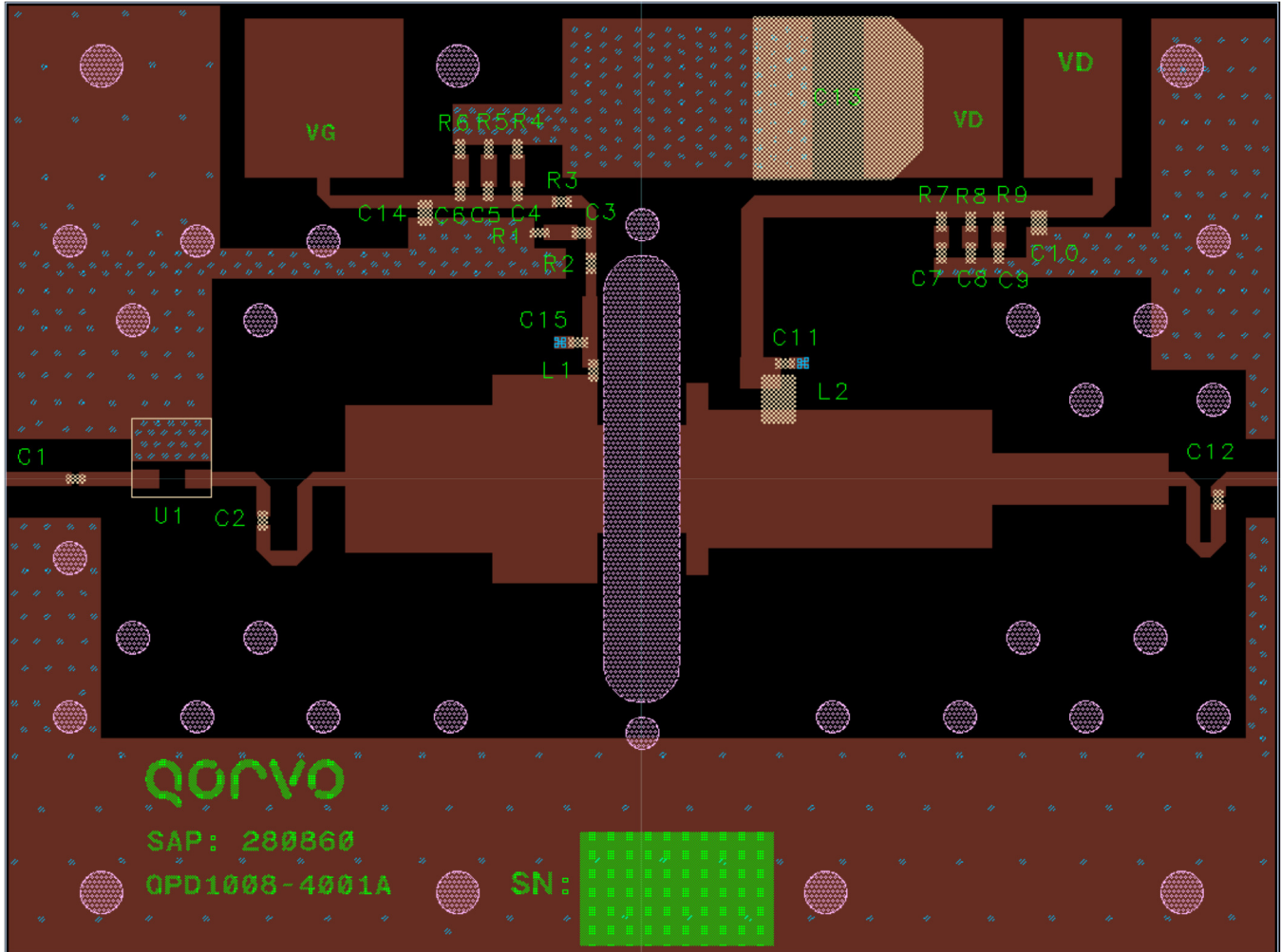
1.1 – 1.5 GHz Application Circuit - Schematic



Bias-up Procedure	Bias-down Procedure
2. Set V_G to -4 V.	3. Turn off RF signal.
4. Set I_D current limit to 300 mA.	4. Turn off V_D
5. Apply 50 V V_D .	5. Wait 2 seconds to allow drain capacitor to discharge
6. Slowly adjust V_G until I_D is set to 260 mA.	7. Turn off V_G
8. Set I_D current limit to 0.6 A (Pulsed operation)	
9. Apply RF.	

1.1 – 1.5 GHz Application Circuit - Layout

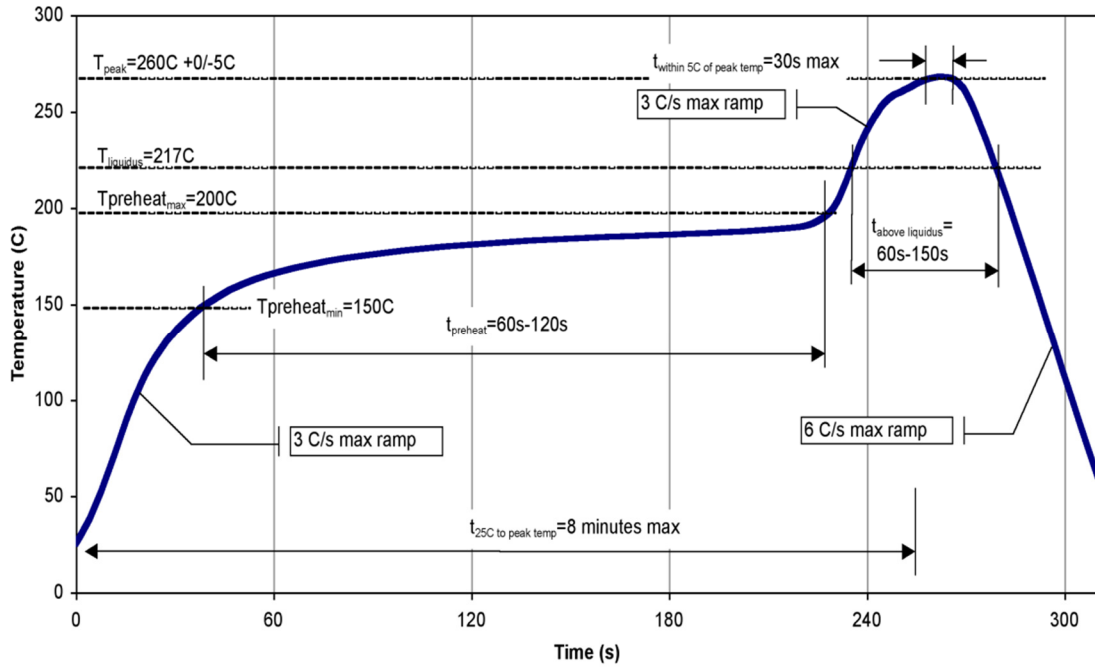
Board material is RO4360G2 0.032" thickness with 1oz copper cladding. EVB dimension is 3" x 4".



1.1 – 1.5 GHz Application Circuit - Bill Of material

Ref Des	Value	Quantity	Part Number	Manufacturer
C1	100 pF	1	0603G101J201S	Capax
C2	3.3 pF	1	600S3R3AT250XT	ATC
C12	3.9 pF	1	600S3R9AT250XT	ATC
C11, C15	22 pF	2	600S220FT250XT	ATC
C3, C7	0.1 uF	2	GRM188R72A104KA35D	Murata
C10, C14	1 uF	2	C2012X7S2A105M125AB	TDK
C13	100 uF, 63 V	1	EEETG1J101UP	Panasonic
R1, R7	50 Ohm	2	CRCW060350R0FKEA-ND	Vishay
R2	10 Ohm	1	CRCW060310R0JNEA	Vishay
L1	10 nH	1	0603CS-10NXJEW	Coilcraft
L2	12.5 nH	1	A04TJLC	Coilcraft
U1	2dB Atten.	1	RFP-250250-4AA2-1	Anaren

Recommended Solder Temperature Profile



Product Compliance Information

ESD Sensitivity Ratings



Caution! ESD Sensitive Device

ESD Rating

ESD Rating: TBD
Value: TBD
Test: Human Body Model (HBM)
Standard: JEDEC Standard JESD22-A114

MSL Rating

MSL Rating: TBD
Test: 260 °C convection reflow
Standard: JEDEC Standard IPC/JEDEC J-STD-020

Solderability

Compatible with lead free soldering processes, 260 °C maximum reflow temperature.

Package lead plating: NiAu

The use of no-clean solder to avoid washing after soldering is recommended.

This part is compliant with EU 2002/95/EC RoHS directive (Restrictions on the Use of Certain Hazardous Substances in Electrical and Electronic Equipment).

This product also has the following attributes:

- Lead Free
- Halogen Free (Chlorine, Bromine)
- Antimony Free
- TBBP-A (C₁₅H₁₂Br₄O₂) Free
- PFOS Free
- SVHC Free

Contact Information

For the latest specifications, additional product information, worldwide sales and distribution locations, and information about Qorvo:

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Tel: +1.972.994.8465
Fax: +1.972.994.8504

For technical questions and application information: Email: info-networks@tqs.com

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